TOSHIBA Field Effect Transistor Silicon N Channel MOS Type ($L^2-\pi$ -MOSV)

2SK2961

Relay Drive, Motor Drive and DC-DC Converter Application

• Low drain-source ON resistance : RDS (ON) = 0.2Ω (typ.) • High forward transfer admittance : $|Y_{fs}| = 2.0 S$ (typ.)

• Low leakage current : $IDSS = 100 \mu A (VDS = 60 V)$

• Enhancement mode : $V_{th} = 0.8 \sim 2.0 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA})$

Maximum Ratings (Ta = 25°C)

Characteris	stics	Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	60	V	
Drain-gate voltage (R	_{GS} = 20 kΩ)	V_{DGR}	60	V	
Gate-source voltage		V_{GSS}	±20	V	
Drain current	DC (Note 1)	I_{D}	2.0	А	
	Pulse (Note 1)	I_{DP}	6.0		
Drain power dissipation	n	P_{D}	0.9	W	
Channel temperature		T _{ch}	150	°C	
Storage temperature ra	ange	T _{stg}	-55~150	°C	

Thermal Characteristics

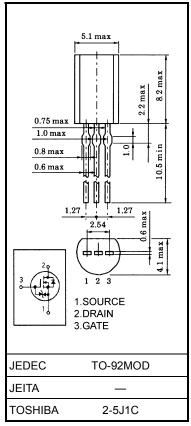
Characteristics	Symbol	Max	Unit
Thermal resistance, channel to ambient	R _{th (ch-a)}	138	°C/W

Note 1: Ensure that the channel temperature does not exceed 150°C.

This transistor is an electrostatic-sensitive device.

Please handle with caution.

Unit: mm



Weight: 0.36 g (typ.)

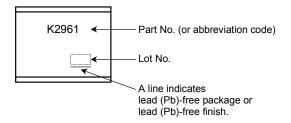
Electrical Characteristics (Ta = 25°C)

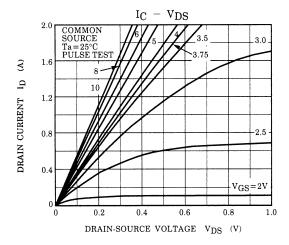
Charac	eteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	rrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V	_	_	±10	μΑ
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = 60 V, V _{GS} = 0 V		_	100	μΑ
Drain-source br	eakdown voltage	V _{(BR) DSS}	I _D = 10 mA, V _{GS} = 0 V	60	_	_	V
Gate threshold v	oltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	0.8	_	2.0	V
Drain-source ON resistance		R _{DS (ON)}	V _{GS} = 4 V, I _D = 1.0 A		0.26	0.38	Ω
			V _{GS} = 10 V, I _D = 1.0 A	_	0.20	0.27	
Forward transfer	admittance	Y _{fs}	V _{DS} = 10 V, I _D = 1.0 A	1.0	2.0	_	S
Input capacitano	e	C _{iss}		_	170	_	pF
Reverse transfe	r capacitance	C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	25	_	
Output capacitance		Coss		_	75	_	
Switching time	Rise time	t _r	$V_{GS} \stackrel{10V}{\underset{OV}{\bigcap}} \stackrel{I_{D}=1A}{\underset{R_{L}=30\Omega}{\bigcap}} V_{OUT}$	_	10	_	
	Turn-on time	t _{on}		_	15	_	ns
	Fall time	t _f		ı	50		115
	Turn-off time	t _{off}	Duty $\leq 1\%$, $t_{\rm w} = 10 \mu \rm s$	_	170	_	
Total gate charge (gate-source plus gate-drain)		Qg			5.8		
Gate-source charge		Q _{gs}	$V_{DD} \approx 48 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 2 \text{ A}$		4.1	_	nC
Gate-drain ("mil	-drain ("miller") Charge Q _{gd}		_	1.7	_		

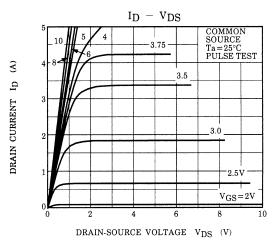
Source-Drain Ratings and Characteristics (Ta = 25°C)

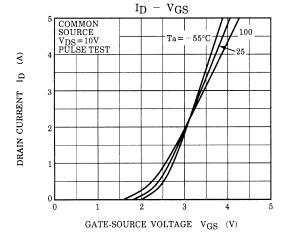
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	-	_	2.0	Α
Pulse drain reverse current (Note 1)	I _{DRP}	_	_	_	6.0	Α
Forward voltage (diode)	V _{DSF}	I _{DR} = 2 A, V _{GS} = 0 V	_	_	-1.5	V
Reverse recovery time	t _{rr}	I _{DR} = 2 A, V _{GS} = 0 V, dI _{DR} / dt = 50 A / µs	_	45	_	ns
Reverse recovery charge	Qrr	1DR = 2 A, VGS = 0 V, αιDR / αι = 30 A / μs	_	40.5	_	nC

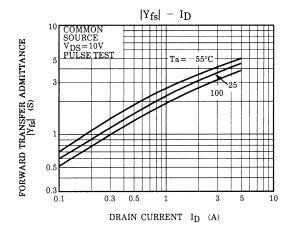
Marking

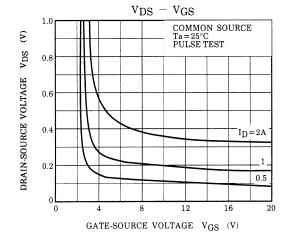


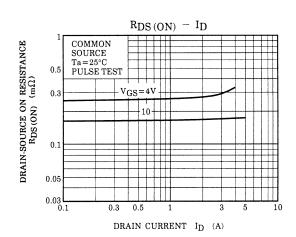


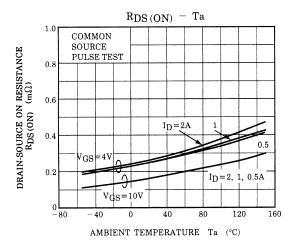


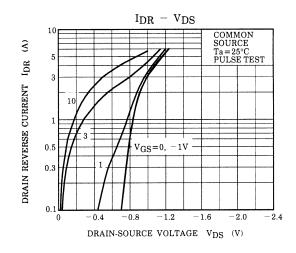


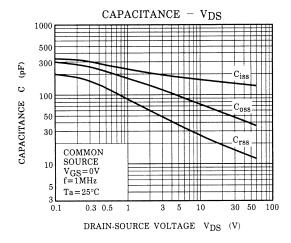


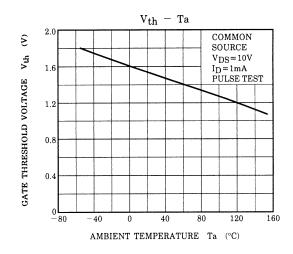


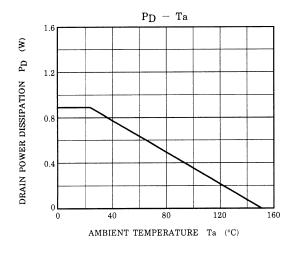


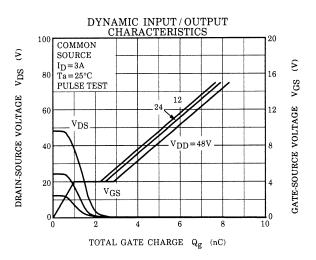




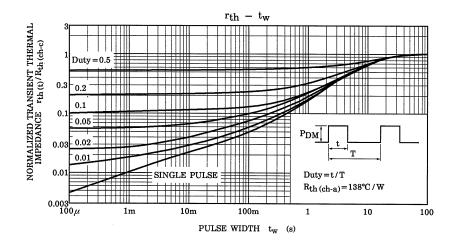


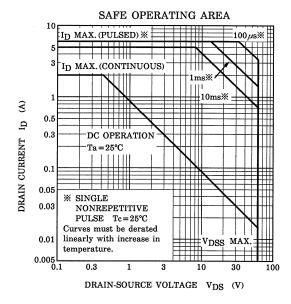






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